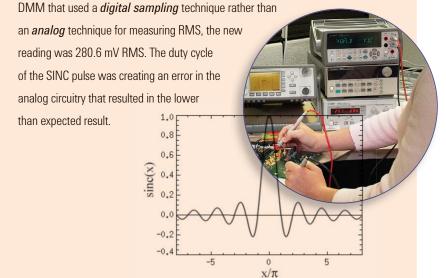


When you use a digital multimeter to measure AC voltages, it is important to know how your DMM makes the measurements and understand your instrument's limitations.

A True RMS (root-mean-square) AC measurement is often described as a measure of the equivalent heating value of the signal, with a relationship to the power dissipated by a resistive load driven by the equivalent DC value. Over the years, true RMS responding multimeters have used a number of techniques to measure this "heating" potential of an applied AC voltage. These techniques have included applying the AC signal to a thermopile and monitoring the resultant temperature, using hardware to generate the root, mean and square functions in an AC-to-DC converter, and employing digital sampling techniques to measure AC. This measurement tip will discuss the advantages and drawbacks of these techniques, as well as describe good practices and cautions regarding making AC measurements.

Snapshot: Making RMS Measurements on Large Crest Factor Signals

An engineer was attempting to measure the RMS value of a 16 kHz repetition rate SINC waveform with a positive peak voltage of 1.0 volts and a negative peak voltage of -0.2 volts. She expected to get an RMS reading of 281 mV RMS. Instead, her DMM was reading 263 mV RMS, nearly 7% low. By using a different





AC-to-DC Converter Effects on RMS measurements

One of the considerations in making RMS measurements with a DMM is the type of AC-to-DC converter used to make the measurement. The thermal technique mentioned earlier is rarely used today. Instead, two techniques are employed, one being analog and the other being digital.

Input Blocking Signal Capacitor Conditioning S/H 0.998 ADC Scaling Output Trigger

Figure 1. Block diagram of an analog AC converter

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Figure 2. Block diagram of a digital sampling AC converter

Analog AC converter

Many mid-range and high-end DMMs use a chain of analog circuits to compute the RMS value of the AC signal. The converter circuitry first squares the input signal. Next, it runs through a circuit that averages the signal. Finally, it passes through circuitry that generates the square root of the signal. The result is an RMS value, independent of the wave shape being applied. This method is fast, accurate and relatively inexpensive to implement. The required analog converters can fit onto a single chip and provide good performance/cost. There are, however, limitations regarding bandwidth, accuracy, crest factor, etc. Be sure to consult your digital multimeter's data sheet to understand these potential limitations for your particular application.

Digital sampling AC converter

A second AC-to-DC converter technique uses direct digital sampling, which is similar to the technique used in modern oscilloscopes. An anti-aliasing filter is placed after the input signal conditioning, and the resultant output is applied directly to the A/D converter. The A/D converter digitizes the input signal at a high sample rate and then calculates the RMS value of the digitized waveform. This digital sampling technique has some advantages over the analog converter just described. For example, you can make faster measurements of AC, and better measurements of pulse trains and other low-duty-cycle signals. However, because of the anti-aliasing filter, high-frequency content such as harmonics will be lost above the bandwidth of the filter.

MEASUREMENT TIP

Some modern meters, such as the Agilent 34410A and 34411A DMMs use digital sampling techniques to measure RMS values. The front end samples the input signal at a 1.4 MHz rate and digitizes the input waveform. This sampling is running at all times, even when the meter is making DC voltage measurements. As a result, it is possible to make a DC voltage measurement and see the peak-to-peak AC measurements simultaneously in a second display.



Figure 3. An example of a DMM that can display both DC and AC voltage measurements simultaneously

Crest Factor Effects

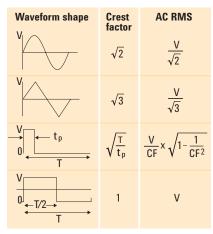


Table 1: Crest factors (CF) for a variety of typical waveform shapes

MEASUREMENT TIP

Crest factor can affect the accuracy of your AC measurement. Traditionally, DMMs include a crest factor derating table that will show the errors introduced at higher crest factors. Often crest factors greater than 3 will begin to cause significant errors. In the case of the digital sampling RMS converter technique used in the Agilent 34410A and 34411A DMM, no additional errors are introduced for crest factors <10. Be sure to consult the data sheet for the DMM you use.

Crest factor is defined as the ratio of the peak value to the RMS value of a waveform. Some common crest factors are shown in Table 1. For a pulse train, the crest factor is approximately equal to square root of the inverse of the duty cycle. Notice however that for a pulse train, crest factor is a composite parameter, dependent on the pulse width and the repetition frequency. One of the advantages of using the digital sampling technique for AC converters described previously is that it is not inherently sensitive to crest factor.

Avoiding Common Measurement Traps

When you make AC measurements with a DMM, pay attention to the traps listed below.

- 1. Measurements below full scale: Most meters specify AC inputs down to 5 or 10 percent of full scale, some even lower. For maximum accuracy, measure as close to full scale as you can. You might need to override auto scaling in some cases. Be careful with high-crest-factor signals not to overload and saturate the meter's input circuitry.
- 2. Settling time: By definition, RMS measurements require time-averaging over multiple periods of the lowest frequency being measured. Be sure to select your DMMs appropriate low-frequency filter to allow for the fundamental to be captured. The lower the AC filter frequency is, the longer the settling time and hence the longer it will take to make the measurement.
- **3. First reading accuracy:** Many DMMs have a large-value DC-blocking capacitor in the input path. You need to allot sufficient time to allow this capacitor to charge, especially when you are measuring low-frequency signals or when you are switching between measurement points that have a large DC offset.
- 4. Low-level measurement errors: When you measure AC voltages less than 100 mV, be aware that these measurements are especially susceptible to errors introduced by extraneous noise sources. An exposed test lead will serve as an antenna and the DMM will measure these unwanted signals as well. Reduce the area of the "antenna," use good shielding techniques, and make sure the AC source and the DMM are connected to the same electrical outlet to minimize ground loops.
- **5. AC loading errors:** The input impedance of a DMM is often in the region of 10 M Ω in parallel with 100 pF. The cabling you use to connect signals to the multimeter adds additional capacitance and loading. As frequency increases, loading will change. For example, at 1 kHz, the input resistance will now be closer to 850 k Ω , and at 100 kHz it will be closer to 16 k Ω .
- **6. Harmonic content:** Signals that are rich in harmonics can produce low reading measurements if the more significant of these components are not included in the measurement. Conversely, it is also possible to measure a higher-than-actual value if only the fundamental is measured. It is important to check the DMMs data sheet to see how much bandwidth you have to work with.

Summary

Making accurate true RMS AC measurements with modern DMMs is simple and straightforward and results in consistent and accurate measurements. However, you need to avoid common traps and pay attention to details. Know your meter and its limitations and use good measurement techniques and you should get accurate results.

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